







SN54AC74, SN74AC74

SCAS521G - AUGUST 1995 - REVISED JULY 2024

SNx4AC74 Dual Positive-Edge-Triggered D-type Flip-Flops with Clear and Preset

1 Features

- 2V to 6V V_{CC} operation
- Inputs accept voltages to 6V
- Max t_{pd} of 10 ns at 5V

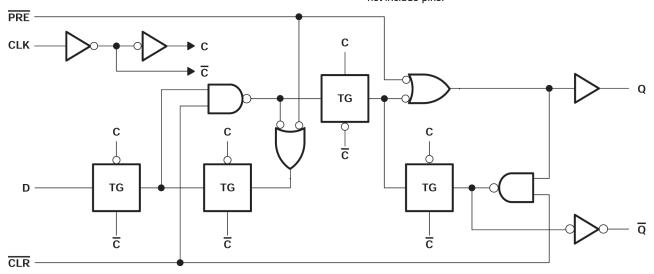
2 Description

The 'AC74 devices are dual positive-edge-triggered D-type flip-flops.

Device Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE (2)	BODY SIZE(3)
	PW (TSSOP, 14)	5 mm × 6.4 mm	5 mm × 4.40 mm
SNx4AC74	D (SOIC, 14)	8.65 mm × 6 mm	8.65 mm × 3.9 mm
	DB (SSOP, 14)	6.2 mm × 7.8 mm	6.2 mm × 5.3 mm
	N (PDIP, 14)	19.3 mm × 9.4 mm	19.3 mm × 6.35 mm
	NS (SOP, 14)	10.2 mm × 7.8 mm	10.3 mm × 5.3 mm

- For more information, see Section 10.
- The package size (length × width) is a nominal value and includes pins, where applicable.
- The body size (length × width) is a nominal value and does not include pins.



Logic Diagram, Each Flip-flop (Positive Logic)



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3 Pin Configuration and Functions

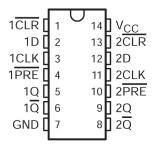
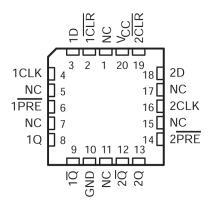


Figure 3-1. SN54AC74 J or W Package; SN74AC74 D, DB, N, NS, or PW Package (Top View)



NC - No internal connection

Figure 3-2. SN54AC74 FK Package (Top View)

P	IN	TYPE ⁽¹⁾	DESCRIPTION
NAME	NO.	ITPE\'	DESCRIPTION
1 CLR	1	Input	Channel 1, Clear Input, Active Low
1D	2	Input	Channel 1, Data Input
1CLK	3	Input	Channel 1, Positive edge triggered clock input
1 PRE	4	Input	Channel 1, Preset Input, Active Low
1Q	5	Output	Channel 1, Output
1 Q	6	Output	Channel 1, Inverted Output
GND	7	_	Ground
2 Q	8	Output	Channel 2, Inverted Output
2Q	9	Output	Channel 2, Output
2 PRE	10	Input	Channel 2, Preset Input, Active Low
2CLK	11	Input	Channel 2, Positive edge triggered clock input
2D	12	Input	Channel 2, Data Input
2 CLR	13	Input	Channel 2, Clear Input, Active Low
V _{CC}	14	_	Positive Supply

Product Folder Links: SN54AC74 SN74AC74

⁽¹⁾ Signal Types: I = Input, O = Output, I/O = Input or Output



4 Specifications

4.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	7	V
V _I (2)	Input voltage range	nput voltage range			
V _O ⁽²⁾	Output voltage range		-0.5	V _{CC} + 0.5	V
I _{IK}	Input clamp current	$(V_I < 0 \text{ or } V_I > V_{CC})$		±20	mA
I _{OK}	Output clamp current	(V _O < 0 or V _O > V _{CC})		±20	mA
Io	Continuous output current	(V _O = 0 to V _{CC})		±50	mA
	Continuous current through V _{CC} or GND	·		±200	mA
T _{stg}	Storage temperature range		-65	150	°C

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

4.2 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

			SN54AC74		SN74A	C74	UNIT
			MIN	MAX	MIN	MAX	UNII
V _{CC}	Supply voltage		2	6	2	6	V
		V _{CC} = 3 V	2.1		2.1		
V _{IH}	High-level input voltage	V _{CC} = 4.5 V	3.15		3.15		V
		V _{CC} = 5.5 V	3.85		3.85		
		V _{CC} = 3 V		0.9		0.9	
V _{IL}	Low-level input voltage	V _{CC} = 4.5 V		1.35		1.35	V
		V _{CC} = 5.5 V		1.65		1.65	
VI	Input voltage		0	V _{CC}	0	V _{CC}	V
Vo	Output voltage		0	V _{CC}	0	V _{CC}	V
		V _{CC} = 3 V		-12		-12	
I _{OH}	High-level output current	V _{CC} = 4.5 V		-24		-24	mA
		V _{CC} = 5.5 V		-24		-24	
		VCC = 3 V		12		12	
I _{OL}	Low-level output current	V _{CC} = 4.5 V		24		24	mA
		V _{CC} = 5.5 V		24		24	
Δt/Δν	Input transition rise or fall rate			8		8	ns/V
T _A	Operating free-air temperature		-55	125	-40	85	°C

All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

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The input and output voltage ratings may be exceeded if the input and output current ratings are observed.



4.3 Thermal Information

THERMAL METRIC ⁽¹⁾	D DB N (SOIC) (SSOP) (PDIP)			NS (SO)	-	
	14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	
R _{θJA} Junction-to-ambient thermal resistance	119.9	96	80	76	145.7	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

4.4 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST COMP	ITIONS	\ \ \	Т	A = 25°C		SN54	AC74	SN74	AC74	UNIT
PARAMETER	TEST COND	IIIONS	V _{CC}	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
			3 V	2.9	4.49		2.9		2.9		
	I _{OH} = -50 μA	I _{OH} = -50 μA		4.4	5.49		4.4		4.4		
			5.5 V	5.4	5.49		5.4		5.4		
V	I _{OH} = −12 mA		3 V	2.56			2.4		2.46		V
V_{OH}	I _{OH} = −24 mA		4.5 V	3.86			3.7		3.76		V
	10H = -24 IIIA		5.5 V	4.86			4.7		4.76		
	I _{OH} = -50 mA ⁽¹⁾		5.5 V				3.85				
	$I_{OH} = -75 \text{ mA}^{(1)}$		5.5 V						3.85		
	Ι _{ΟL} = 50 μΑ		3 V		0.002	0.1		0.1		0.1	
			4.5 V		0.001	0.1		0.1		0.1	
			5.5 V		0.001	0.1		0.1		0.1	
.,	I _{OL} = 12 mA		3 V			0.36		0.5		0.44	V
V _{OL}	I _{OL} = 24 mA		4.5 V			0.36		0.5		0.44	V
	10L - 24 IIIA		5.5 V			0.36		0.5		0.44	
	I _{OL} = 50 mA ⁽¹⁾		5.5 V					1.65			
	$I_{OL} = 75 \text{ mA}^{(1)}$		5.5 V							1.65	
Data pins	V = V or CND		5.5 V			±0.1		±1		±1	^
Control pins	$V_I = V_{CC}$ or GND		0.5 V			±0.1		±1		±1	μA
cc	V _I = V _{CC} or GND,	I _O = 0	5.5 V			2		40		20	μΑ
C _i	$V_I = V_{CC}$ or GND		5 V		3						pF

⁽¹⁾ Not more than one output should be tested at a time, and the duration of the test should not exceed 2 ms.

4.5 Timing Requirements, $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$

over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

			T _A = 2	5°C	5°C SN54AC		SN74A	SN74AC74	
			MIN	MAX	MIN	MAX	MIN	MAX	UNIT
f _{clock}	Clock frequency			100		70		95	MHz
	t _w Pulse duration	PRE or CLR low	5.5		8		7		
ι _w		CLK	5.5		8		7		ns
	Setup time, data before	Data	4		5		4.5		
ι _{su}		PRE or CLR inactive	0		0.5		0		ns

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over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

		T _A = 2	T _A = 25°C		C74	SN74AC74		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	ONIT
t _h	Hold time, data after CLK↑	0.5		0.5		0.5		ns

4.6 Timing Requirements, $V_{CC} = 5 V \pm 0.5 V$

over recommended operating free-air temperature range, $V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$ (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

			T _A = 2	5°C	SN54A	C74	SN74A	C74	UNIT	
			MIN	MAX	MIN	MAX	MIN	MAX	UNII	
f _{clock}	Clock frequency			140		95		125	MHz	
4	t _w Pulse duration	PRE or CLR low	4.5		5.5		5			
ι _W		CLK	4.5		5.5		5		ns	
+	Setup time, data before	Data	3		4		3		no	
L _{SU}	su CLK↑	PRE or CLR inactive	0		0.5		0		ns	
t _h	Hold time, data after CLK↑	•	0.5		0.5		0.5		ns	

4.7 Switching Characteristics, $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$

over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	T,	T _A = 25°C			C74	SN74A	UNIT	
PARAMETER	PROM (INPUT)	10 (001701)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
f _{max}			100	125		70		95		MHz
t _{PLH}	PRE or CLR	Q or $\overline{\mathbb{Q}}$	3.5	8	12	1	13	2.5	13	ns
t _{PHL}	PRE OI CLK	QuiQ	4	10.5	12	1	14	3.5	13.5	
t _{PLH}		Q or $\overline{\mathbb{Q}}$	4.5	8	13.5	1	17.5	4	16	no
t _{PHL}	CLK	QUIQ	3.5	8	14	1	13.5	3.5	14.5	ns

4.8 Switching Characteristics, V_{CC} = 5 V ± 0.5 V

over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	EDOM (INDUT)	TO (OUTPUT)	T,	T _A = 25°C			C74	SN74A	UNIT	
PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
f _{max}			140	160		95		125		MHz
t _{PLH}	PRE or CLR	Q or $\overline{\mathbb{Q}}$	2.5	6	9	1	9.5	2	10	ns
t _{PHL}	FIXE OF CER	QUIQ	3	8	9.5	1	10.5	2.5	10.5	
t _{PLH}	CLK	Q or Q	3.5	6	10	1	12	3	10.5	ns
t _{PHL}	CLK	QUIQ	2.5	6	10	1	10	2.5	10.5	

4.9 Operating Characteristics

 $V_{CC} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$

PARAMETER		TEST CO	TYP	UNIT	
C_{pd}	Power dissipation capacitance	C _L = 50 pF,	f = 1 MHz	45	pF

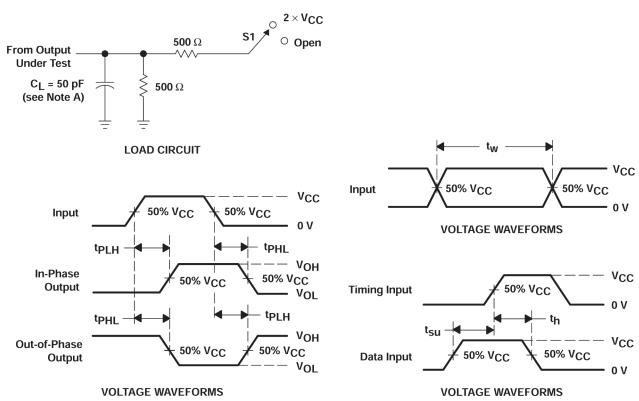
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5 Parameter Measurement Information



- A. C_L includes probe and jig capacitance.
- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_0 = 50 Ω , t_r v 2.5 ns, t_f v 2.5 ns.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 5-1. Load Circuit and Voltage Waveforms

TEST	S1
t _{PLH} /t _{PHL}	Open

Product Folder Links: SN54AC74 SN74AC74



6 Detailed Description

6.1 Overview

A low level at the preset (\overline{PRE}) or clear (\overline{CLR}) input sets or resets the outputs, regardless of the levels of the other inputs. When \overline{PRE} and \overline{CLR} are inactive (high), data at the data (D) input meeting the setup-time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold-time interval, data at D can be changed without affecting the levels at the outputs.

6.2 Functional Block Diagram

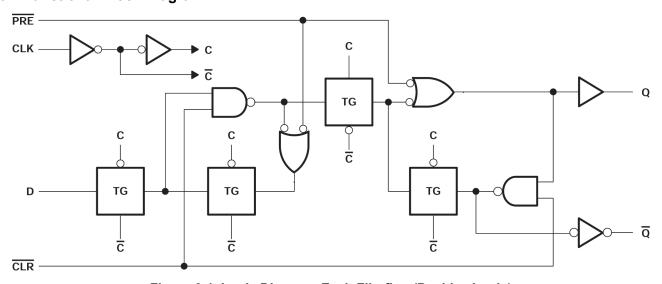


Figure 6-1. Logic Diagram, Each Flip-flop (Positive Logic)

6.3 Device Functional Modes

Table 6-1. Function Table

		OUTPUTS			
PRE	CLR	CLK	D	Q	Q
L	Н	Х	Х	Н	L
Н	L	Х	Χ	L	Н
L	L	Х	Χ	H ⁽¹⁾	H ⁽¹⁾
Н	Н	1	Н	Н	L
Н	Н	1	L	L	Н
Н	Н	L	Χ	Q_0	Q ₀

(1) This configuration is unstable; that is, it does not persist when either PRE or CLR returns to its inactive (high) level.

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7 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

7.1 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. A 0.1- μ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. The 0.1- μ F and 1- μ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results, as shown in the following layout example.

7.2 Layout

7.2.1 Layout Guidelines

7.2.2 Layout Example

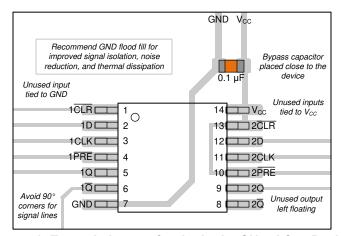


Figure 7-1. Example Layout for the in the SNx4AC74 Package



8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

8.1 Documentation Support (Analog)

8.1.1 Related Documentation

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 8-1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
SN54AC74	Click here	Click here	Click here	Click here	Click here	
SN74AC74	Click here	Click here	Click here	Click here	Click here	

8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

8.4 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

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8.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision F (October 2003) to Revision G (July 2024)

Page

Product Folder Links: SN54AC74 SN74AC74

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10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	3, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1,		RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)		
5962-88520012A	Active	Production	LCCC (FK) 20	55 TUBE	BE No SNPB N/A for Pkg Type -55 to 125		5962- 88520012A SNJ54AC 74FK		
5962-8852001CA	Active	Production	CDIP (J) 14	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8852001CA SNJ54AC74J
5962-8852001DA	Active	Production	CFP (W) 14	25 TUBE	No	SNPB	N/A for Pkg Type -55 to 125		5962-8852001DA SNJ54AC74W
5962-8852001VDA	Active	Production	CFP (W) 14	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8852001VD A SNV54AC74W
SN74AC74D	Obsolete	Production	SOIC (D) 14	-	-	Call TI	Call TI	-40 to 85	AC74
SN74AC74DBR	Active	Production	SSOP (DB) 14	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AC74
SN74AC74DR	Active	Production	SOIC (D) 14	2500 LARGE T&R	Yes	NIPDAU NIPDAU	Level-1-260C-UNLIM	-40 to 85	AC74
SN74AC74N	Active	Production	PDIP (N) 14	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	SN74AC74N
SN74AC74NSR	Active	Production	SOP (NS) 14	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AC74
SN74AC74PW	Obsolete	Production	TSSOP (PW) 14	-	-	Call TI	Call TI	-40 to 85	AC74
SN74AC74PWR	Active	Production	TSSOP (PW) 14	2000 LARGE T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	-40 to 85	AC74
SN74AC74PWRG4	Active	Production	TSSOP (PW) 14	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AC74
SNJ54AC74FK	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 88520012A SNJ54AC 74FK
SNJ54AC74J	Active	Production	CDIP (J) 14	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8852001CA SNJ54AC74J
SNJ54AC74W	Active	Production	CFP (W) 14	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8852001DA SNJ54AC74W

⁽¹⁾ Status: For more details on status, see our product life cycle.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.



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(3) RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN54AC74, SN54AC74-SP, SN74AC74:

Catalog: SN74AC74, SN54AC74

■ Enhanced Product : SN74AC74-EP, SN74AC74-EP

Military: SN54AC74

Space: SN54AC74-SP

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

• Enhanced Product - Supports Defense, Aerospace and Medical Applications





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- Military QML certified for Military and Defense Applications
- Space Radiation tolerant, ceramic packaging and qualified for use in Space-based application



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TAPE AND REEL INFORMATION



TAPE DIMENSIONS WHO WE PI AD BO W Cavity AO A

A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AC74DBR	SSOP	DB	14	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
SN74AC74DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74AC74DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74AC74DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74AC74NSR	SOP	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74AC74PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AC74PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AC74PWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AC74PWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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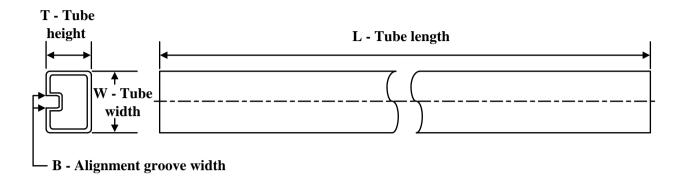
*All dimensions are nominal

Device	Package Type Package Drawing		Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AC74DBR	SSOP	DB	14	2000	356.0	356.0	35.0
SN74AC74DR	SOIC	D	14	2500	353.0	353.0	32.0
SN74AC74DR	SOIC	D	14	2500	356.0	356.0	35.0
SN74AC74DR	SOIC	D	14	2500	353.0	353.0	32.0
SN74AC74NSR	SOP	NS	14	2000	356.0	356.0	35.0
SN74AC74PWR	TSSOP	PW	14	2000	353.0	353.0	32.0
SN74AC74PWR	TSSOP	PW	14	2000	356.0	356.0	35.0
SN74AC74PWRG4	TSSOP	PW	14	2000	353.0	353.0	32.0
SN74AC74PWRG4	TSSOP	PW	14	2000	356.0	356.0	35.0



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TUBE

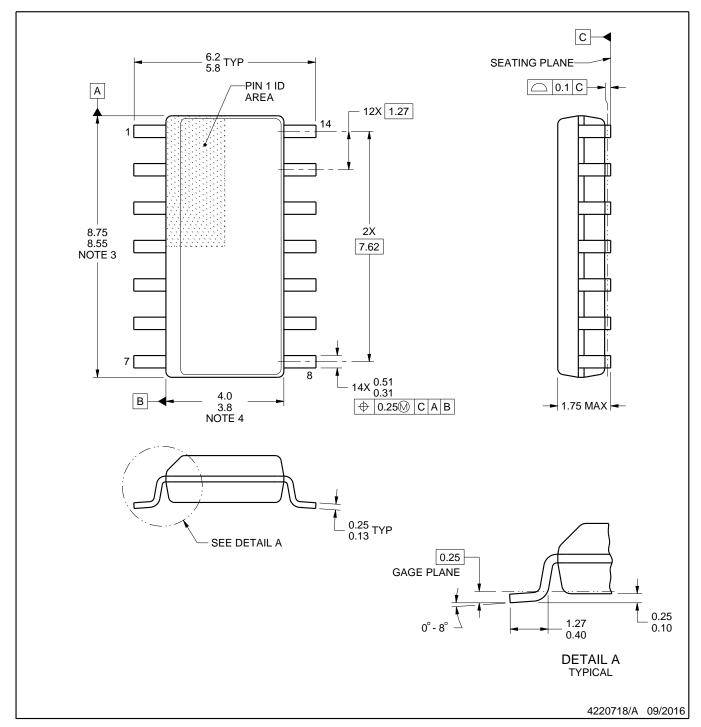


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-88520012A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-8852001DA	W	CFP	14	25	506.98	26.16	6220	NA
5962-8852001VDA	W	CFP	14	25	506.98	26.16	6220	NA
SN74AC74N	N	PDIP	14	25	506	13.97	11230	4.32
SN74AC74N	N	PDIP	14	25	506	13.97	11230	4.32
SN74AC74NE4	N	PDIP	14	25	506	13.97	11230	4.32
SN74AC74NE4	N	PDIP	14	25	506	13.97	11230	4.32
SNJ54AC74FK	FK	LCCC	20	55	506.98	12.06	2030	NA
SNJ54AC74W	W	CFP	14	25	506.98	26.16	6220	NA



SMALL OUTLINE INTEGRATED CIRCUIT



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
- 5. Reference JEDEC registration MS-012, variation AB.



SMALL OUTLINE INTEGRATED CIRCUIT

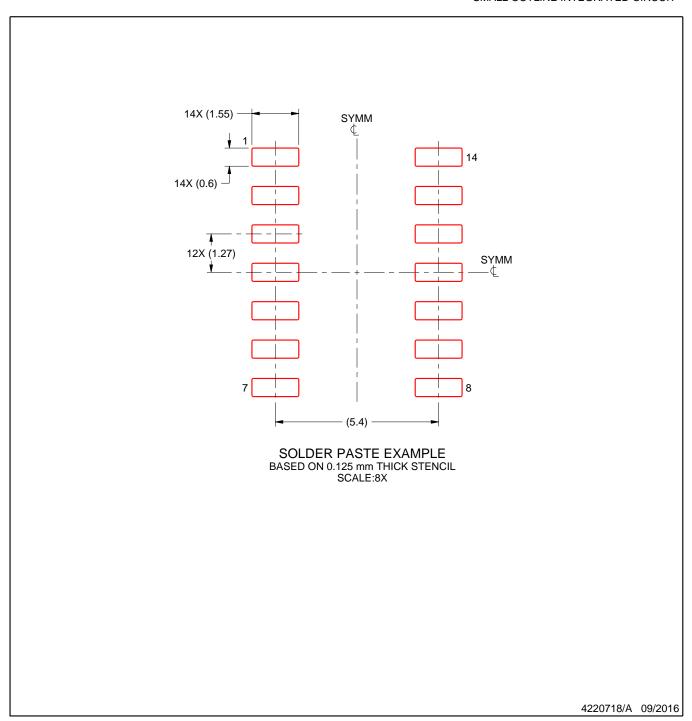


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE

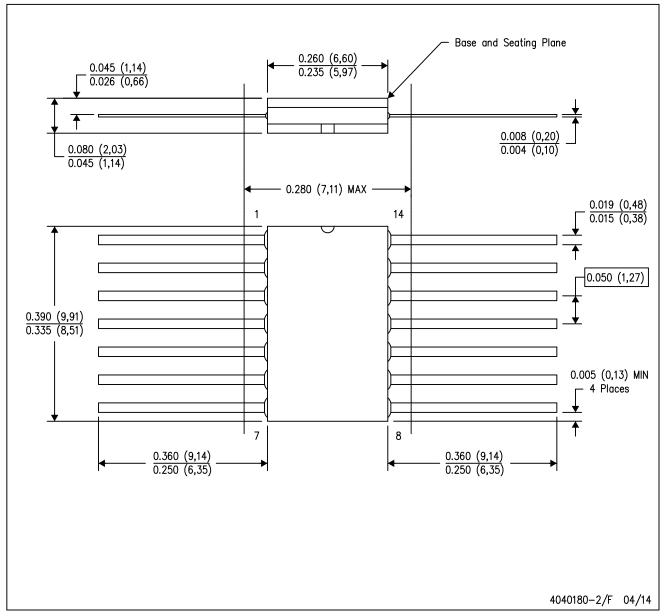


- a. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



W (R-GDFP-F14)

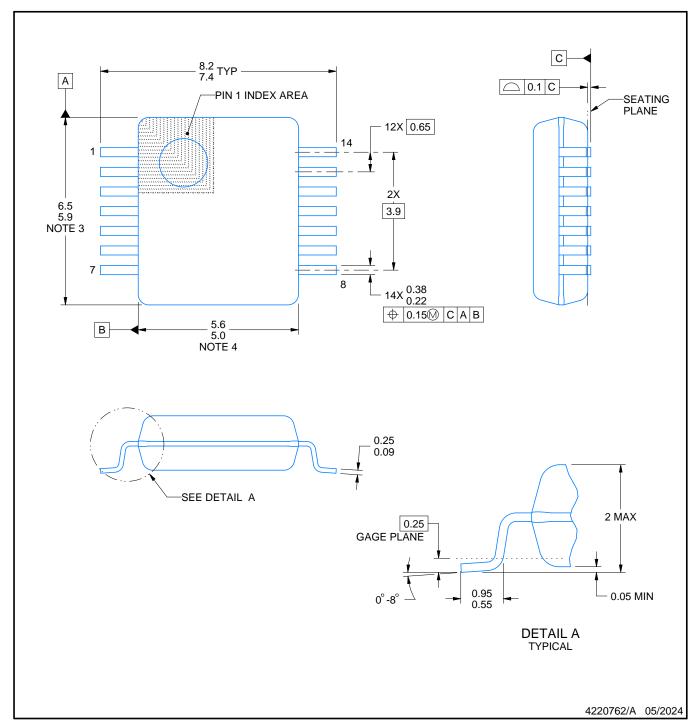
CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within MIL STD 1835 GDFP1-F14





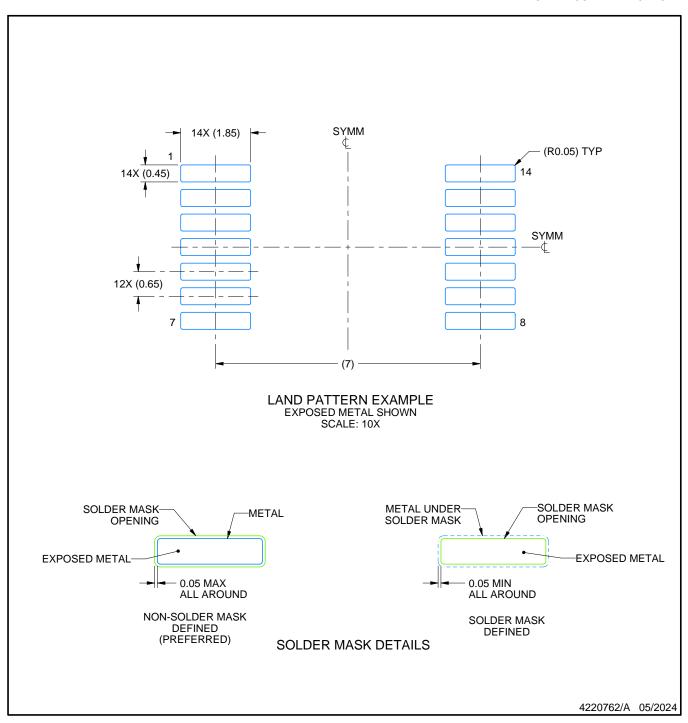


- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

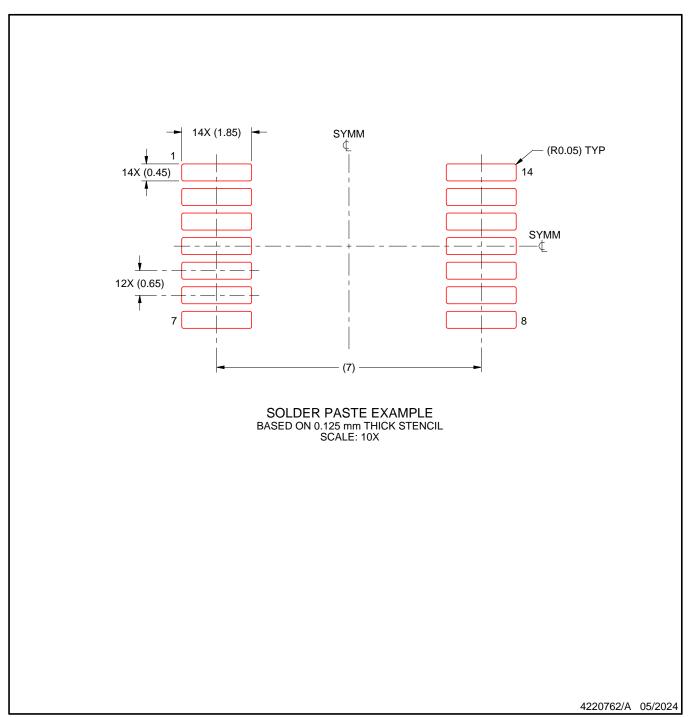
 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
 4. Reference JEDEC registration MO-150.





NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



NOTES: (continued)

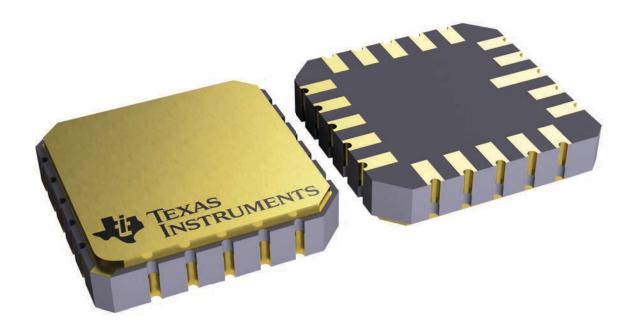
- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



8.89 x 8.89, 1.27 mm pitch

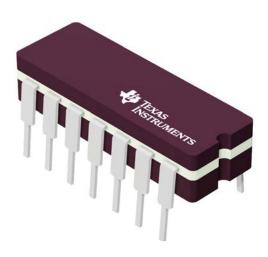
LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4040083-5/G





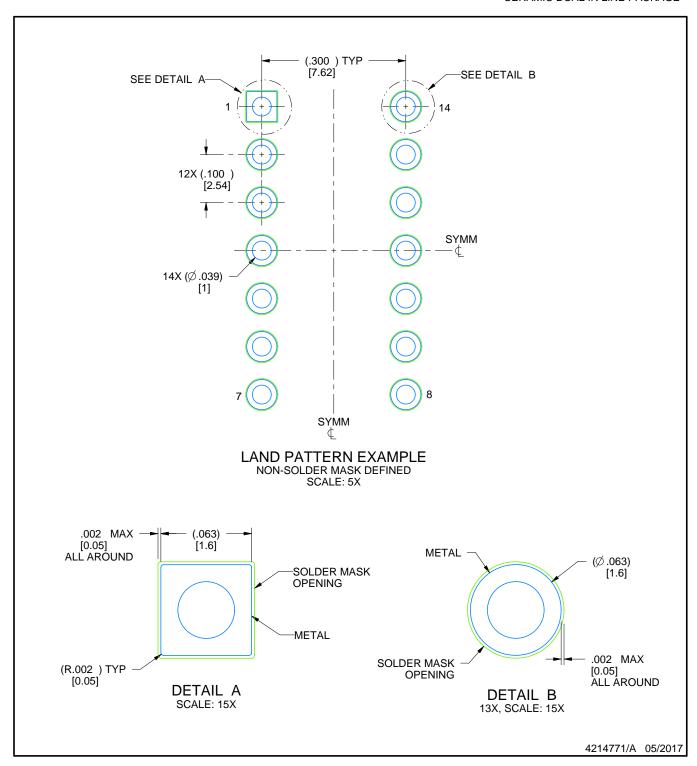
CERAMIC DUAL IN LINE PACKAGE



- 1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This package is hermitically sealed with a ceramic lid using glass frit.
- His package is remitted by sealed with a ceramic its using glass mit.
 Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
 Falls within MIL-STD-1835 and GDIP1-T14.



CERAMIC DUAL IN LINE PACKAGE





N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

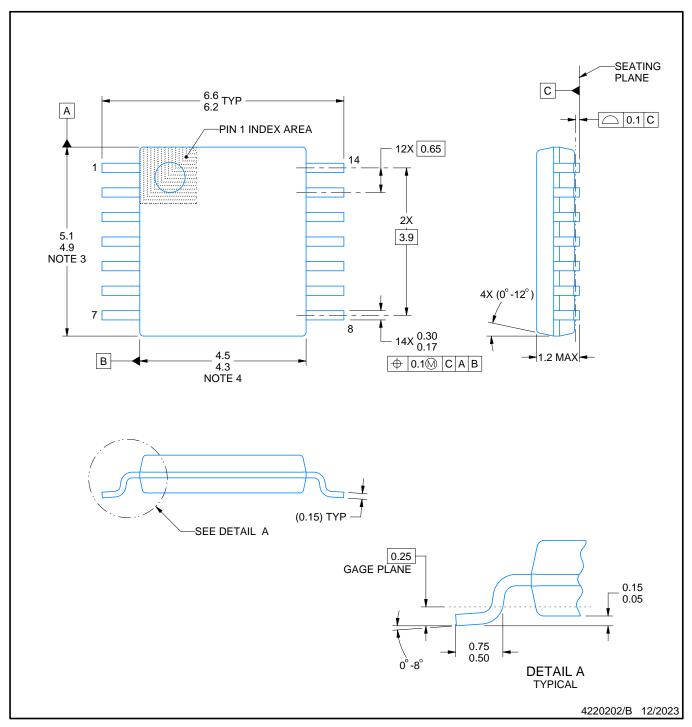
16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





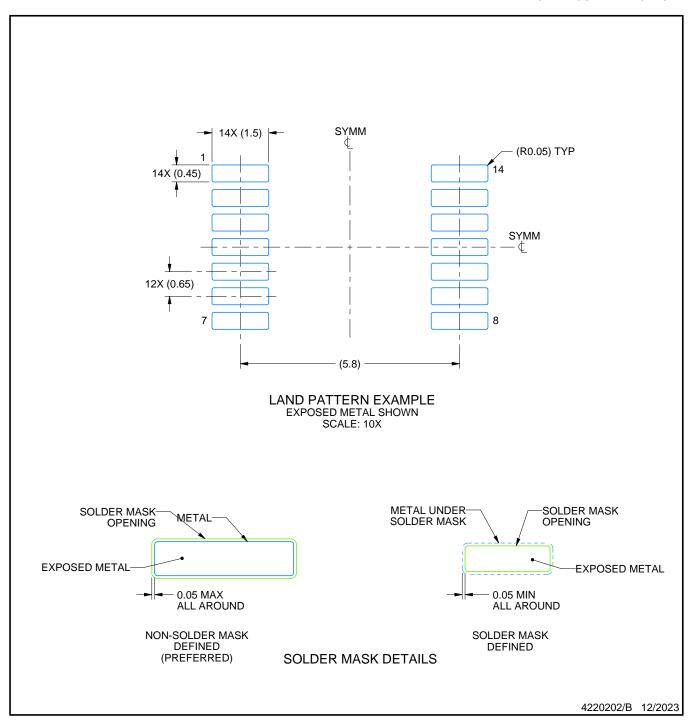


- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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